

Application/Control No.	Applicant(s)/Patent u Reexamination	Applicant(s)/Patent under Reexamination	
10/622,697	YAMAUCHI, KAZUN	YAMAUCHI, KAZUNARI	
Examiner	Art Unit		

2622

Nhan T. Tran

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB) Text search all classes - see search history printout	9/2/2007	NT